



*Nemko USA, Inc.
11696 Sorrento Valley Rd., Suite F
San Diego, CA 92121-1024
Phone (858) 755-5525 Fax (858) 452-1810*



CLASS II PERMISSIVE CHANGE REPORT
PART 2/22/24

**DECLARATION OF CONFORMANCE
TEST REPORT**

For The **Kyocera module 200 wireless module with a new
antenna as installed in the VT100**

Model: **Module 200 with new antenna**
FCC ID: OVFKWC-M200.

PREPARED FOR:

Kyocera Wireless

10300 Campus Point Drive

San Diego, CA 92121

Rand Efron

Model: VT100

PREPARED ON JULY 26TH 2004

REPORT NUMBER 2004 024367-EMC

PROJECT NUMBER: 2004 024367 EMC

Nemko USA, Inc.		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	2 of 36

DOCUMENT HISTORY

REVISION	DATE	COMMENTS
	8-2-2004	Prepared By: Chip Fluery
	8-2-2004	Initial Release: R. L. Hill

NOTE: Nemko USA, Inc. hereby makes the following statements so as to conform to Chapter 10 (Test Reports) Requirements of ANSI C63.4 (1992) "Methods and Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz":

- o The unit described in this report was received at Nemko USA, Inc.'s facilities on July 13th, 2004. Testing was performed on the unit described in this report on July 13, 2004.
- o The Test Results reported herein apply only to the Unit actually tested, and to substantially identical Units.
- o This report does not imply the endorsement of the Federal Communications Commission (FCC), NVLAP or any other government agency.

This Report is the property of Nemko USA, Inc., and shall not be reproduced, except in full, without prior written approval of Nemko USA, Inc. However, all ownership rights are hereby returned unconditionally to Kyocera, and approval is hereby granted to Kyocera and its employees and agents to reproduce all or part of this report for any legitimate business purpose without further reference to Nemko USA, Inc.

Nemko USA, Inc.		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	3 of 36

TABLE OF CONTENTS

DOCUMENT HISTORY	2
CERTIFICATION	5
1. ADMINISTRATIVE DATA AND TEST SUMMARY	6
1.1. ADMINISTRATIVE DATA	6
1.2. TEST SUMMARY	6
2. SYSTEM CONFIGURATION	7
2.1. SYSTEM COMPONENTS AND POWER CABLES	7
2.2. DEVICE INTERCONNECTION AND I/O CABLES	7
2.3. TEST CONFIGURATION	8
3. DESCRIPTION OF TEST SITE AND EQUIPMENT	9
3.1. DESCRIPTION OF TEST SITE	9
4. DESCRIPTION OF TESTING METHODS	10
4.1. INTRODUCTION	10
4.2. CONFIGURATION AND METHODS OF MEASUREMENTS FOR CONDUCTED EMISSIONS	12
4.3. CONFIGURATION AND METHODS OF MEASUREMENTS FOR FREQUENCY IDENTIFICATION	14
4.4. CONFIGURATION AND METHODS OF MEASUREMENTS FOR RADIATED EMISSIONS	16
5.0 TEST RESULTS	18
5.1 EIRP MEASUREMENTS	18
5.2 RADIATED EMISSIONS TEST DATA – PART 22 (POWER OUTPUT, LOW, MID AND HIGH)	19
5.2 RADIATED EMISSIONS TEST DATA – PART 22 (POWER OUTPUT, LOW, MID AND HIGH)	19
5.2.1 CDMA800 - PART 22 (POWER OUTPUT, LOW, MID AND HIGH)	19
5.2.2 FM - PART 22 (POWER OUTPUT, LOW, MID AND HIGH)	19
5.2.3 PCS - PART 24 (POWER OUTPUT, LOW, MID AND HIGH)	21
5.3.1 CDMA800 - PART 22 (POWER OUTPUT, LOW, MID AND HIGH)	21
5.3 CDMA800/FM/PCS - RECEIVE MODE MID CHANNEL	21
 TEST SETUP DIAGRAMS	
Figure 1. General EUT Test Setup Diagram	11
Figure 2. Conducted Emissions Test Setup Diagram	13
Figure 3. Frequency ID of Radiated Emissions Test Setup Diagram	15
Figure 4. Radiated Emissions Test Setup Diagram	17
Photograph 1. Conducted Emissions Test Configuration	24

<i>Nemko USA, Inc.</i>		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	4 of 36

TEST CONFIGURATION PHOTOGRAPHS

Photograph 1. Conducted Emissions Test Configuration	24
Photograph 2. Radiated Emissions Test Configuration	25
Photograph 3. EUT Back cover	26
Photograph 4. Front picture of EUT	27
Photograph 5. EUT with cover off – showing new antenna	28

APPENDICES

Kyocera Wireless	1
A. Conducted & Radiated Emissions Measurement Uncertainties	29
B. Nemko USA, Inc.'s Test Equipment & Facilities Calibration Program.....	31
C. FCC and NVLAP Accreditation.....	33

Nemko USA, Inc.		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	5 of 36

CERTIFICATION

Nemko USA, Inc., an independent Electromagnetic Compatibility (EMC) Test Laboratory, produced this Test Report and performed the Radio Frequency Interference (RFI) testing and data evaluation contained herein.

Nemko USA, Inc.'s measurement facility is currently registered with the United States Federal Communications Commission (FCC) in accordance with the provisions of 47 United States Code (CFR) Part 2, Subpart I, Section 2.948(a). A current description of Nemko USA, Inc.'s measurement facility is on file with the FCC. Nemko USA Inc. has additionally satisfied the FCC that it complies with the requirements set forth in 47 CFR Part 2, Subpart I, Section 2.948(d) regarding the accreditation of EMC laboratories.

The RFI testing, test data collection and test data evaluation were accomplished in accordance with the ANSI C63.4-1992 Standard, and in accordance with the applicable sections of the FCC rules (47 CFR Parts 2 and 15). The testing was also accomplished in accordance with Industry Canada's ICES-003 standard for unintentional radiating device per EMCAB-3, Issue 3 (May 1998). The administrative summary of this test report provides a description of the test sample.

I hereby certify that the test data, test data evaluation, and equipment configurations used to compile this test report are a true and accurate representation of the test sample's radio frequency interference characteristics as of the test date(s), and, for the design of the test sample.



Ricky L. Hill

Manager of EMC Operations

Nemko USA, Inc.		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	6 of 36

1. ADMINISTRATIVE DATA AND TEST SUMMARY

1.1. Administrative Data

CLIENT: **Kyocera Wireless**
10300 Campus Point Drive
San Diego, CA 92121

CONTACT: Rand Effron

DATE (S) OF TEST: July 13, 2004

EQUIPMENT UNDER TEST (EUT): VT100 (MODULE 200 with new antenna)
Model VT100
Antenna Model CDMA Dual Band/GPS

Condition Upon Receipt Suitable for Test

TEST SPECIFICATION: FCC, Part 2/22/24 Testing for power output and Radiated spurious only Class II permissive change adding additional antenna.

1.2. Test Summary

<i>Specification</i>	<i>Frequency Range</i>	<i>Compliance Status</i>
FCC, CFR 47, Part 2:1046 (Verify Part 22/24)	1049.4 – 1908.75 MHz	PASS
FCC, CFR 47, Part 2:1053 (Verify Part 22/24)	1649.42 - 20996 MHz	PASS
FCC, CFR 47, Part 15 Verify receiver compliance	1065 – 19000MHZ	PASS

Test Supervisor: 

R. L. Hill, Nemko USA, Inc.

Refer to the test results section for further details.

Nemko USA, Inc.		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	7 of 36

2.SYSTEM CONFIGURATION

2.1. System Components and Power Cables

DEVICE	MANUFACTURER		POWER CABLE
	MODEL #	SERIAL #	
EUT – Wireless Module	Kyocera 200 Module installed in VT100		N/A
EUT Power Supply	N/A		N/A
Support Equipment	N/A		N/A

2.2. Device Interconnection and I/O Cables

CONNECTION	I/O CABLE
N/A	N/A

Nemko USA, Inc.		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	8 of 36

2.3. Test Configuration

The VT100 is an Vehicle tracking device using the PCS and Cellphone bands. The VT100 device has a Kyocera Module 200 certified device installed using a new antenna. This test report is to verify the MODULE 200 module with the new antenna still meets the FCC requirements. The MODULE 200 is an approved modular transmitter with the FCC ID: OVFKWC-M200. The intent of this testing was to show that the already granted device would still pass with an alternative antenna. Therefore testing is only for a class II permissive change.

Device: Wireless Transmitter

Model: VT100

The following design modifications were made to the EUT during testing.

No design modifications were made to the EUT during testing.

<i>Nemko USA, Inc.</i>		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	9 of 36

3. DESCRIPTION OF TEST SITE AND EQUIPMENT

3.1. Description of Test Site

The test site is located at 11696 Sorrento Valley Road, Suite F, San Diego, CA 92121. The site is physically located 18 miles Northwest of downtown San Diego. The general area is a valley 1.5 miles east of the Pacific Ocean. This particular part of the valley tends to minimize ambient levels, i.e. radio and TV broadcast stations and land mobile communications. The three and ten-meter Open Area Test Site (OATS) is located behind the office/lab building. It conforms to the normalized site attenuation limits and construction specifications as set in the EN 55022 (1987), CISPR 16 and 22 (1985) and ANSI C63.4-1992 documents. The OATS normalized site attenuation characteristics are verified for compliance every year.

<i>Nemko USA, Inc.</i>		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	10 of 36

4. DESCRIPTION OF TESTING METHODS

4.1. Introduction

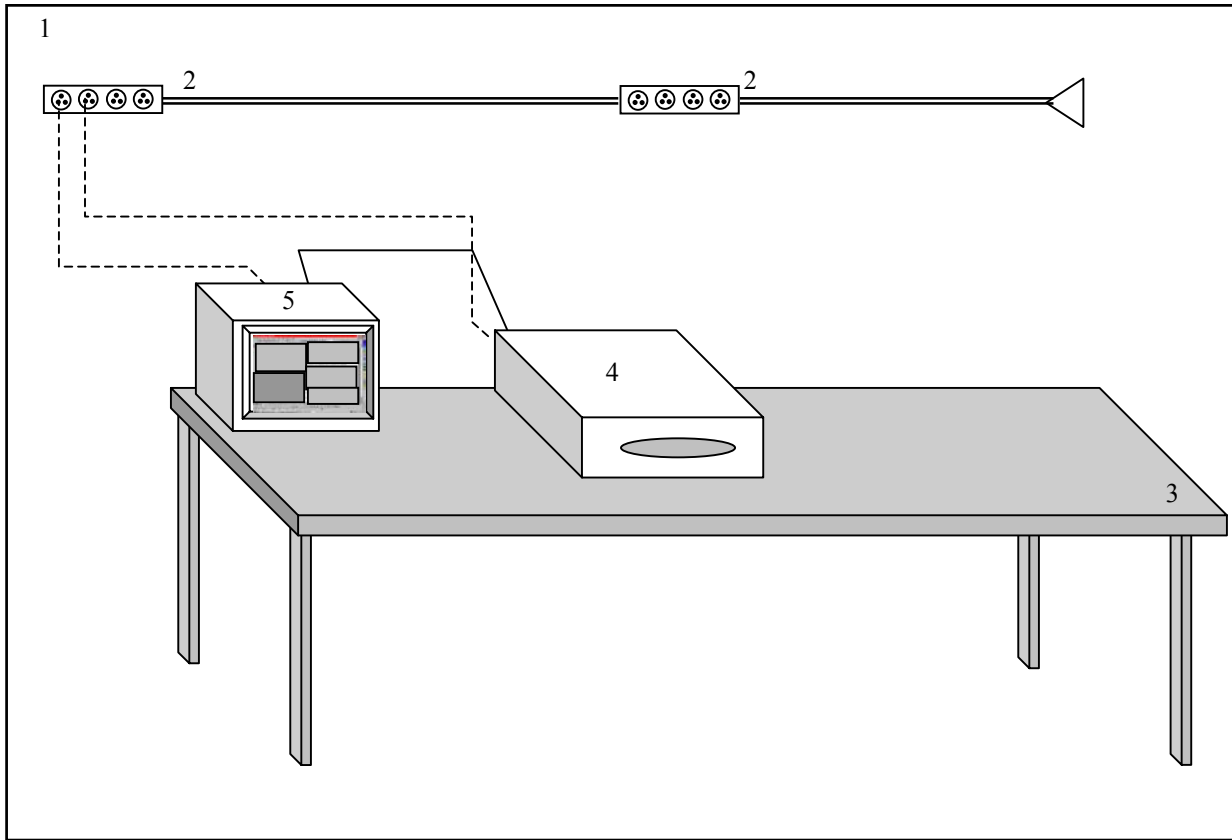
As required in 47 CFR, Parts 2 and 15, the methods employed to test the radiated and conducted emissions (as applicable) of the EUT are those contained within the American National Standards Institute (ANSI) document C63.4-1992, titled "Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz." All applicable FCC Rule Sections that provide further guidance for performance of such testing are also observed.

For General Test Configuration please refer to Figure 1 on the following page.

Digital devices sold in Canada are required to comply with the Interference Causing Equipment Standard for Digital Apparatus, ICES-003. These test methods and limits are specified in the Canadian Standards Association's (CSA) Standard C108.8-M1983 (1-1-94 version) and are "essentially equivalent" with FCC, Part 15 and CISPR 22 (EN55022) rules for unintentional radiators per EMCAB-3, Issue 3 (May 1998). No further testing is required for compliance to ICES-003.

Nemko USA, Inc.		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	11 of 36

Figure 1. General EUT Test Setup Diagram



NOT TO SCALE

CONFIGURATION LEGEND

- 1. Test Laboratory
- 2. AC Power for Peripheral Devices (120V, 60 cycles, single phase)
- 3. Non-Conducting tables 80 cm above ground plane
- 4. EUT: Wireless Base Station

<i>Nemko USA, Inc.</i>		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	12 of 36

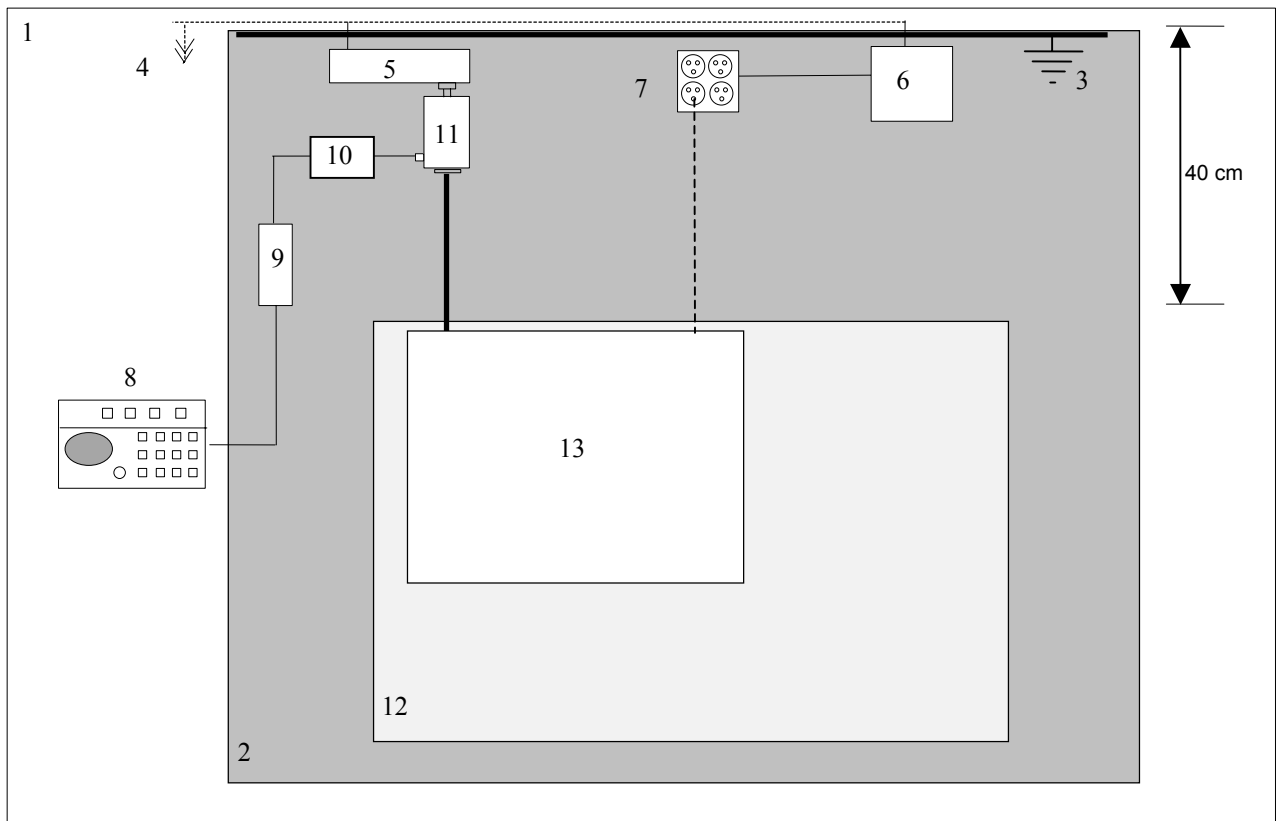
4.2. Configuration and Methods of Measurements for Conducted Emissions

Section 7 of ANSI C63.4 determines the general configuration of the EUT and associated equipment, as well as the test platform for conducted emissions testing. Tabletop devices are placed on a non-conducting surface 80 centimeters above the ground plane floor and 40 centimeters from the ground plane wall. The EUT and associated system are configured to operate continuously, representing a “normally operating” mode. The EUT is powered via a Line Impedance Stabilization Network (LISN). The emissions are recorded using the required bandwidth of 9 kHz in the quasi-peak mode. The average amplitude is also observed employing a 10 kHz bandwidth to determine the presence of broadband RFI. When such interference is caused by broadband sources (as defined by the FCC and ANSI Rules), the deviation guidelines contained in Section 11.3.1 of ANSI C63.4 are employed, which allows a correction factor of 13 dB to be subtracted from the quasi-peak reading. The emission levels are then compared to the applicable FCC limits to determine compliance.

For Conducted Emissions Test Configuration please refer to Figure 2 on the following page.

Nemko USA, Inc.		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	13 of 36

Figure 2. Conducted Emissions Test Setup Diagram



NOT TO SCALE

CONFIGURATION LEGEND

1. Test Laboratory (6 X 6 meters)
2. Ground Plane (15 square meters)
3. Vertical Conducting Wall (Grounded through Ground Plane via 10' ground rod)
4. AC Power for Devices
5. Power Line Filter, Lindgren, 120 dB, 30 amp
6. Line Impedance Stabilization Network (LISN) for peripheral devices
7. Power Distribution Box for peripheral devices
8. Spectrum Analyzer with Quasi-Peak Adapter
9. High Pass Filter
10. Transient Limiter
11. LISN for EUT
12. Non-Conducting table 80 cm above ground plane
13. EUT: Wireless Base Station and Associated System

<i>Nemko USA, Inc.</i>		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	14 of 36

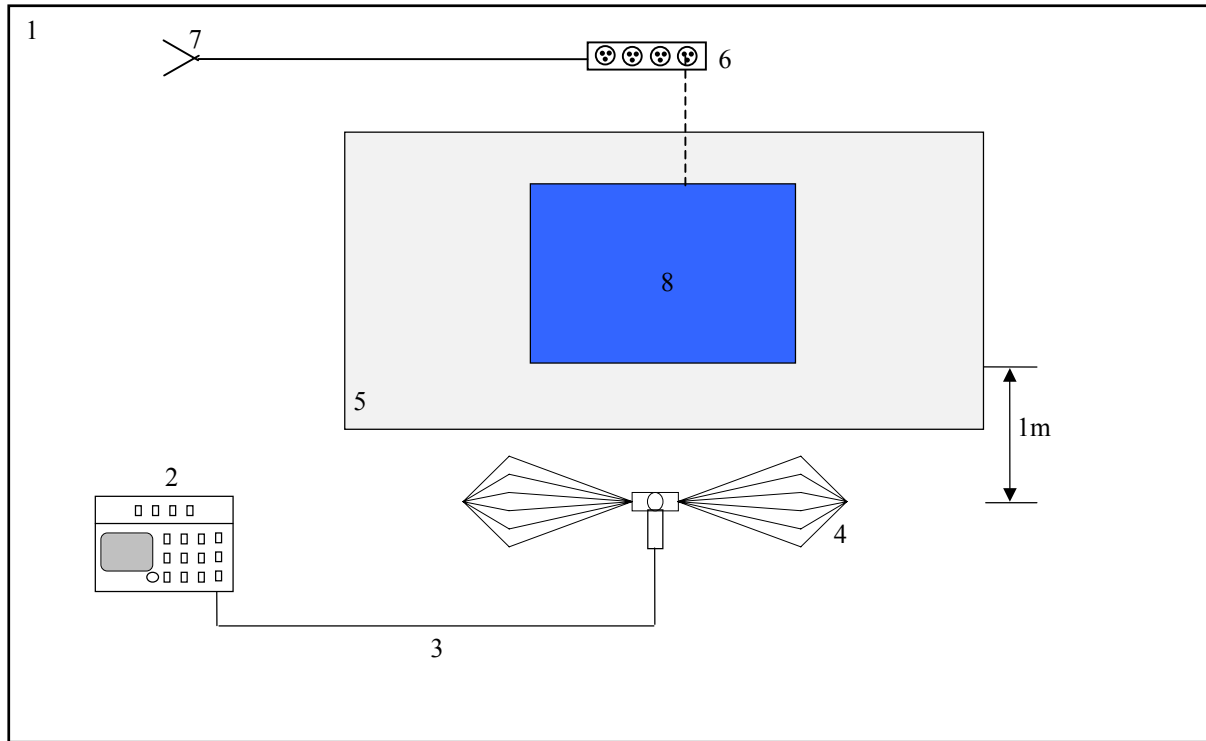
4.3. Configuration and Methods of Measurements for Frequency Identification

When performing all testing of equipment, the actual emissions of the EUT are segregated from ambient signals present within the laboratory or the open-field test range. Preliminary testing is performed to ensure that ambient signals are sufficiently low to allow for proper observation of the emissions from the EUT. Incoming power lines are filtered using a 120 dB, 30-ampere; 115/208-volt filter to assist in reducing ambient signals for tests of levels of conducted emissions. Ambients within the laboratory are compared to those noted at the nearby open-field site to discriminate between signals produced from the EUT and ambient signals. In the event that a significant emission is produced by the EUT at a frequency which is also demonstrating significant ambient signals, the spectrum analyzer is placed in the peak mode, the bandwidth is narrowed, the EUT's signal is centered on the analyzer, the scan width is expanded to 50 kHz while monitoring the audio to ensure that only the EUT signal is present, the analyzer is switched to quasi-peak mode, and the level of the EUT signal is recorded.

For Frequency ID Test Configuration please refer to Figure 3 on the following page.

Nemko USA, Inc.		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	15 of 36

Figure 3. Frequency ID of Radiated Emissions Test Setup Diagram



NOT TO SCALE

CONFIGURATION LEGEND

- 1. Test Laboratory
- 2. Spectrum Analyzer with Quasi-Peak Adapter
- 3. Coax interconnect from Antenna to Spectrum Analyzer
- 4. Receive Antenna (basic relative position)
- 5. Non-Conducting table 80 cm above ground plane
- 6. Power strip for EUT and peripherals
- 7. AC power for devices
- 8. EUT Wireless Base Station and Associated System

Nemko USA, Inc.		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	16 of 36

4.4. Configuration and Methods of Measurements for Radiated Emissions

Section 8 of ANSI C63.4 determines the general configuration and procedures for measuring the radiated emissions of equipment under test. Initially, the primary emission frequencies are identified inside the test lab by positioning a broadband receive antenna one meter from the EUT to locate frequencies of significant radiation. Next, the EUT and associated system are placed on a turntable on a ten meter open area test site (registered with the FCC in accord with its Rules and ANSI C63.4) and the receive antenna is located at a distance of ten meters from the EUT.

The EUT and associated system are configured to operate continuously, representing a “normally operating” mode. All significant radiated emissions are recorded when maximum radiation on each frequency is observed, in accordance with part 8 of ANSI C63.4-1992 and Section 15.33 of the FCC Rules. To ensure that the maximum emission at each discrete frequency of interest is observed, the receive antenna is varied in height from one to four meters and rotated to horizontal and vertical polarities, and the turntable is also rotated to determine the worst emitting configuration. The numerical results of the test are included herein to demonstrate compliance.

The numerical results that are applied to the emissions limits are arrived at by the following method:

Example: $A=RR+CL+AF$

A = Amplitude dBuV/M

RR = Receiver Reading dBuV

CL = cable loss dB

AF = antenna factor dBm-1

Example Frequency = 110MHz

18.5 dBuV (spectrum analyzer reading)

+3.0 dB (cable loss @ frequency)

21.5 dBuV

+15.4 dBm-1 (antenna factor @ frequency)

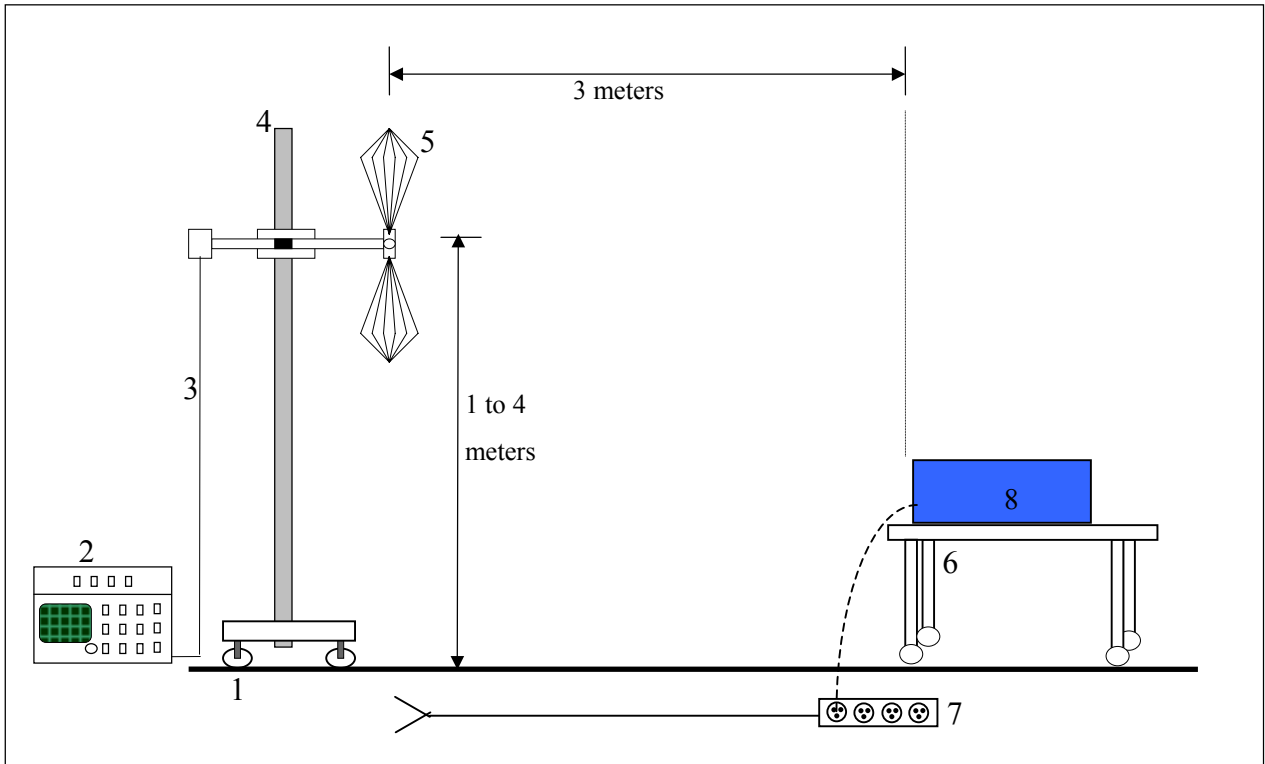
36.9 dBuV/M Final adjusted value

The final adjusted value is then compared to the appropriate emission limit to determine compliance.

For Radiated Emissions Test Configuration please refer to Figure 4 on the following page.

DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	17 of 36

Figure 4. Radiated Emissions Test Setup Diagram



NOT TO SCALE

CONFIGURATION LEGEND

1. Ground plane (11 X 17 meters)
2. Spectrum Analyzer with Quasi-Peak Adapter
3. Coax interconnect from Receive Antenna to Spectrum Analyzer
4. Antenna Mast with motorized mounting assembly
5. Receive Antenna (basic relative position)
6. Non-Conducting table 80 cm above ground plane
7. AC power for devices
8. EUT: Wireless Base Station and Associated System

Nemko USA, Inc.		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	18 of 36

5.0 TEST RESULTS

5.1 EIRP Measurements

EIRP PCS/CDMA800/FM modes of operation

	Frequency	Measurement	Path Loss	antenna factor	dBµV/m	Calculated dBm	Signal Sub	Watts	Grant Watts
PCS	1851.25	89.3	3	28.2	120.50	25.27	23.80	0.24	0.35
	1880	88.5	3	29	120.50	25.27	24.20	0.26	0.35
	1908.75	90.5	2	29	121.50	26.27	25.00	0.32	0.35
CDMA800	824.7	90.5	2	32	124.50	29.27	28.10	0.65	1.10
	836.49	91	2	31	124.00	28.77	27.70	0.59	1.10
	848.31	89.7	2	32	123.70	28.47	27.60	0.58	1.10
FM	824.04	91.2	2	31	124.20	28.97	27.80	0.60	1.10
	836.49	92.4	2	31	125.40	30.17	29.10	0.81	1.10
	848.31	89.8	2	32	123.80	28.57	27.70	0.58	1.10

Measurement using - Rhode and Swartz - FSEK 30
Horn antenna/Log Periodic antenna

Nemko USA, Inc.		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	19 of 36

5.2 Radiated Emissions Test Data – Part 22 (Power output, Low, Mid and High)

5.2.1 CDMA800 - Part 22 (Power output, Low, Mid and High)



NEMKO USA, Inc.

San Diego Headquarters:
11696 Sorrento Valley Rd.
San Diego, CA 92121
Tel: (858) 755-5525
Fax: (858) 452-1810

Radiated Emissions Data											
Preliminary										Page <u>1</u> of <u>3</u>	
Client Name :		<u>Kyocera Wireless Corporation</u>									
EUT Name :		<u>VT100</u>									
EUT Model # :		<u>VT100</u>									
EUT Part # :											
EUT Serial # :		<u>N/A</u>									
EUT Config. :		<u>Transmit mode CDMA - 800</u>									
Specification		<u>FCC Part 22</u>						Reference :			
Rod. Ant. # :		<u>NA</u>		Temp. (deg. C) :		<u>23</u>		Date : <u>7/13/2004</u>			
Bicon Ant.#:		<u>NA</u>		Humidity (%) :		<u>55</u>		Time : <u>NA</u>			
Log Ant.#:		<u>NA</u>		EUT Voltage :		<u>NA</u>		Staff : <u>Chip Fleury</u>			
DRG Ant. # :		<u>529</u>		EUT Frequency :		<u>NA</u>		Photo ID: <u>NA</u>			
Dipole Ant.#:		<u>NA</u>		Phase:		<u>NA</u>		Peak Bandwidth: <u>1 MHz</u>			
Cable#:		<u>60ft</u>		Location:		<u>RN# 90579</u>		Video Bandwidth <u>1 MHz</u>			
Preamp#:		<u>40db</u>		Distance:		<u>3m</u>					
Spec An.#:		<u>711</u>									
QP #:		<u>NA</u>									
PreSelect#:		<u>NA</u>									
Meas. Freq. (MHz)	Vertical (dBuV) pk	Horizontal (dBuV) pk	CF (db)	Max Level (dBm) pk	Spec. Limit (dBm) pk	Margin dB pk	EUT Rotation	Ant. Height	Pass Fail Unc.	Comment	
1673	85	81.5	-11.5	-21.73	-13.0	-8.7	230.0	1.2	Pass		
2509.5	79	74	-5	-21.23	-13.0	-8.2	90.0	1.0	Pass		
3346	59	59.3	-1.3	-37.23	-13.0	-24.2	0	1	Pass		
4182.5	60	55	2.2	-33.03	-13.0	-20.0	150.0	1.3	Pass		
5018.9	55	55	5.4	-34.83	-13.0	-21.8	100.0	1.1	Pass		
5855.4	50	50	6.2	-39.03	-13.0	-26.0			Pass	NF	
6691.9	47	47	7.5	-40.73	-13.0	-27.7			Pass	NF	
7528.4	46	46	11.8	-37.43	-13.0	-24.4			Pass	NF	
8364.9	48	48	12.5	-34.73	-13.0	-21.7			Pass	NF	
1649.4	72.5	68.5	-11.5	-34.23	-13.0	-21.2	250.0	1.2	Pass		
2474.6	71	66	-5.9	-30.13	-13.0	-17.1	220.0	1.4	Pass		
3298.8	55	55	-1.3	-41.53	-13.0	-28.5	230.0	1.3	Pass		
4123.5	58	55.5	2.2	-35.03	-13.0	-22.0	180	1.2	Pass		
4948.2	56	55	1.8	-37.43	-13.0	-24.4	150.0	1.1	Pass		
5772.9	50	50	6.2	-39.03	-13.0	-26.0			Pass	NF	
6597.6	50	50	7.5	-37.73	-13.0	-24.7	180.0	1.0	Pass		
7422.3	47	47	10.6	-37.63	-13.0	-24.6			Pass	NF	
8247	48	48	12.5	-34.73	-13.0	-21.7			Pass	NF	
1696	83	78	-11.5	-23.73	-13.0	-10.7	30.0	1.5	Pass		
2544	77	71.25	-5	-28.98	-13.0	-16.0	90.0	1.2	Pass		
3392	59	56	-1.3	-37.53	-13.0	-24.5	180.0	1.0	Pass		
4240	60	54	2.2	-33.03	-13.0	-20.0	180.0	1.4	Pass		
5088	55	56	5.4	-33.83	-13.0	-20.8	30.0	2.0	Pass		
5936	50	50	6.2	-39.03	-13.0	-26.0			Pass	NF	
6784	47	47	7.5	-40.73	-13.0	-27.7			Pass	NF	
7632	47	47	11.8	-36.43	-13.0	-23.4			Pass	NF	
8480	48	48	12.5	-34.73	-13.0	-21.7			Pass	NF	

5.2.2 FM - Part 22 (Power output, Low, Mid and High)

DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	20 of 36



NEMKO USA, Inc.

San Diego Headquarters:
11696 Sorrento Valley Rd.
San Diego, CA 92121
Tel: (858) 755-5525
Fax: (858) 452-1810

Radiated Emissions Data

Page 1 of 3

Preliminary _____
Client Name : Kyocera Wireless Corporation
EUT Name : VT100
EUT Model # : VT100
EUT Part # : _____
EUT Serial # : N/A
EUT Config : Transmit mode FM

Specification FCC Part 22 Reference : _____
Rod. Ant. # : NA Temp. (deg. C) : 23 Date : 7/13/2004
Bicon Ant.#: NA Humidity (%) : 55 Time : NA
Log Ant.#: NA EUT Voltage : NA Staff : Chip Fleury
DRG Ant. # : 529 EUT Frequency : NA Photo ID: NA
Dipole Ant.#: NA Phase: NA Peak Bandwidth: 1 MHz
Cable#: 60ft Location: RN# 90579 Video Bandwidth 1 MHz
Preamp#: 40db Distance: 3m
Spec An.#: 711
QP #: NA
PreSelect#: NA

Meas. Freq. (MHz)	Vertical (dBuV) pk	Horizontal (dBuV) pk	CF (db)	Max Level (dBm) pk	Spec. Limit (dBm) pk	Margin dB pk	EUT Rotation	Ant. Height	Pass Fail Unc.	Comment
1673	86.5	81	-11.5	-20.23	-13.0	-7.2	270.0	2.0	Pass	
2509.5	77	74.5	-5	-23.23	-13.0	-10.2	90.0	1.4	Pass	
3346	62.2	59	-1.3	-34.33	-13.0	-21.3	180	1.3	Pass	
4182.5	60	57	2.2	-33.03	-13.0	-20.0	180.0	1.3	Pass	
5018.9	55	60	5.4	-29.83	-13.0	-16.8	80.0	1.5	Pass	
5855.4	50	50	6.2	-39.03	-13.0	-26.0			Pass	NF
6691.9	52	49	7.5	-35.73	-13.0	-22.7	10.0	1.3	Pass	
7528.4	46	46	11.8	-37.43	-13.0	-24.4			Pass	NF
8364.9	48	48	12.5	-34.73	-13.0	-21.7			Pass	NF
1649.4	78	68.5	-11.5	-28.73	-13.0	-15.7	250.0	1.2	Pass	
2474.6	77	70	-5.9	-24.13	-13.0	-11.1	90.0	1.0	Pass	
3298.8	60	58	-1.3	-36.53	-13.0	-23.5	180.0	1.1	Pass	
4123.5	57.5	56	2.2	-35.53	-13.0	-22.5	180	1.3	Pass	
4948.2	55	54	1.8	-38.43	-13.0	-25.4	160.0	1.4	Pass	
5772.9	50	50	6.2	-39.03	-13.0	-26.0			Pass	NF
6597.6	53	51	7.5	-34.73	-13.0	-21.7	0.0	1.0	Pass	
7422.3		47	10.6	-37.63	-13.0	-24.6			Pass	NF
8247	48	48	12.5	-34.73	-13.0	-21.7			Pass	NF
1696	81.5	78.5	-11.5	-25.23	-13.0	-12.2	270.0	2.0	Pass	
2544	77	71.25	-5	-28.98	-13.0	-16.0	90.0	1.2	Pass	
3392	62	57	-1.3	-34.53	-13.0	-21.5	180.0	1.0	Pass	
4240	62	57	2.2	-31.03	-13.0	-18.0	180.0	1.4	Pass	
5088	55	57	5.4	-32.83	-13.0	-19.8	30.0	2.0	Pass	
5936	50	50	6.2	-39.03	-13.0	-26.0			Pass	NF
6784	50	47	7.5	-37.73	-13.0	-24.7	180.0	1.2	Pass	
7632	47	47	11.8	-36.43	-13.0	-23.4			Pass	NF
8480	48	48	12.5	-34.73	-13.0	-21.7			Pass	NF

Nemko USA, Inc.		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	21 of 36

5.2.3 PCS - Part 24 (Power output, Low, Mid and High)



NEMKO USA, Inc.

San Diego Headquarters:
11696 Sorrento Valley Rd.
San Diego, CA 92121
Tel: (858) 755-5525
Fax: (858) 452-1810

Radiated Emissions Data

Page 1 of 3

Preliminary _____
 Client Name : Kyocera Wireless Corporation
 EUT Name : VT100
 EUT Model # : VT100
 EUT Part # : _____
 EUT Serial # : N/A
 EUT Config : Transmit mode PCS

Specification FCC Part 24 Reference : _____
 Rod. Ant. #: NA Temp. (deg. C) : 23 Date : 7/12/2004
 Bicon Ant. #: NA Humidity (%) : 55 Time : NA
 Log Ant. #: NA EUT Voltage : NA Staff : Chip Fleury
 DRG Ant. # : 529 EUT Frequency : NA Photo ID: NA
 Dipole Ant. #: NA Phase: NA Peak Bandwidth: 1 MHz
 Cable #: 60ft Location: RN# 90579 Video Bandwidth 1 MHz
 Preamp #: 40db Distance: 3m
 Spec An. #: 835
 QP #: NA
 PreSelect #: NA

Meas. Freq. (MHz)	Vertical (dBuV) pk	Horizontal (dBuV) pk	CF (db)	Max Level (dBm) pk	Spec. Limit (dBm) pk	Margin dB pk	EUT Rotation	Ant. Height	Pass Fail Unc.	Comment
3760	78.26	80	0.1	-17.13	-13.0	-4.1	210.0	1.4	Pass	
5640	53	56	6.2	-35.03	-13.0	-22.0	180.0	1.0	Pass	
7520	50	50	11.8	-35.43	-13.0	-22.4			Pass	NF
9400	46	46	14.11	-37.12	-13.0	-24.1			Pass	NF
11280	44	44	19	-34.23	-13.0	-21.2			Pass	NF
13160	43	43	25.2	-29.03	-13.0	-16.0			Pass	NF
15040	40	40	29.9	-27.33	-13.0	-14.3			Pass	NF
16920	37	37	30.4	-29.83	-13.0	-16.8			Pass	NF
18800	31	31	42.8	-23.43	-13.0	-10.4			Pass	NF
20690	30	30	43.5	-23.73	-13.0	-10.7			Pass	NF
3702.5	80	78	0.1	-17.13	-13.0	-4.1	90.0	1.3	Pass	
5553.8	53	53	6.2	-38.03	-13.0	-25.0	0.0	1.0	Pass	
7405	48	48	10.6	-38.63	-13.0	-25.6			Pass	NF
9256.3	47	47	14.11	-36.12	-13.0	-23.1	90.0	1.2	Pass	
11108	44	44	19	-34.23	-13.0	-21.2			Pass	NF
12959	43	43	21.7	-32.53	-13.0	-19.5			Pass	NF
14810	40	40	30.1	-27.13	-13.0	-14.1			Pass	NF
16661	37	37	30.4	-29.83	-13.0	-16.8			Pass	NF
18513	31	31	42.8	-23.43	-13.0	-10.4			Pass	NF
20364	30	30	43.5	-23.73	-13.0	-10.7			Pass	NF
3817.5	78	77	0.1	-19.13	-13.0	-6.1	100.0	1.4	Pass	
5726.3	54	56	6.2	-35.03	-13.0	-22.0	90.0	1.0	Pass	
7635	48	48	11.8	-37.43	-13.0	-24.4			Pass	NF
9543.8	47	47	13.81	-36.42	-13.0	-23.4			Pass	NF
11453	44	44	19	-34.23	-13.0	-21.2			Pass	NF
13361	43	43	25.2	-29.03	-13.0	-16.0			Pass	NF
15270	40	40	29.9	-27.33	-13.0	-14.3			Pass	NF
17179	37	37	35.5	-24.73	-13.0	-11.7			Pass	NF
19088	31	31	42.8	-23.43	-13.0	-10.4			Pass	NF
20996	30	30	43.5	-23.73	-13.0	-10.7			Pass	NF

5.3.1 CDMA800 - Part 22 (Power output, Low, Mid and High)

5.3 CDMA800/FM/PCS - Receive mode mid channel

Nemko USA, Inc.		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	23 of 36

Client	Helicomm	EUT Name	Wireless Transmitter			
PAN #	24-209-HEL	EUT Model	IP Link 1000			
	<i>Device Type</i>	<i>Model #</i>	<i>Asset #</i>	<i>Used</i>	<i>Cal Done</i>	<i>Cal Due</i>
Pre-Amplifier						
Amplifier, HP	8447A	342				
Amplifier, Mini-Circuits	ZHL-1042J	819				
Amplifier, HP	8447A	166	X	Internal	Internal	
Amplifier, HP	8447A	603				
Amplifier, HP	8449A	317				
Amplifier, Mini-Circuits	ZHL-1042J	630				
Amplifier, Mini-Circuits	ZHL-2	635	X	3/3/04	3/3/05	
Antenna OATS #1 (South)						
Antenna, Biconical	3110	116	X	6/22/03	6/22/04	
Antenna, Log Periodic	3146	110	X	7/21/03	7/21/04	
Antenna, Ridged Guide	3115	752	X	7/05/03	7/05/04	
Antenna, Loop	ALR-25M					
Spectrum Analyzer / Receiver						
Spectrum Analyzer	1088.3494.30	R & S	835	830320/002	12-30-04	
Quasi-Peak Adapter, HP	85650A	438	X	9/10/03	3/10/04	
Spectrum Analyzer Display, HP	85662A	534	X	9/25/03	3/25/04	
Spectrum Analyzer, HP	8568B	107	X	9/25/03	3/25/04	

<i>Nemko USA, Inc.</i>		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	24 of 36

Photograph 1. Conducted Emissions Test Configuration

N/A

Nemko USA, Inc.		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	25 of 36

Photograph 2. Radiated Emissions Test Configuration



<i>Nemko USA, Inc.</i>		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	26 of 36



Photograph 3. EUT Back cover

<i>Nemko USA, Inc.</i>		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	27 of 36



Photograph 4. Front picture of EUT

<i>Nemko USA, Inc.</i>		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	28 of 36



Photograph 5. EUT with cover off – showing new antenna

Nemko USA, Inc.		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	29 of 36

APPENDIX A

A. Conducted & Radiated Emissions Measurement Uncertainties

1. Introduction

ISO Standard 17025 and ANSI/NCSL Z540-1(1994) require that all measurements contained in a test report be “traceable”. “Traceability” is defined in the *International Vocabulary of Basic and General Terms in Metrology* (ISO: 1993) as: “the property of the result of a measurement... whereby it can be related to stated references, usually national or international standards, through an unbroken chain of comparisons, *all having stated uncertainties*”.

The purposes of this Appendix are to “state the *Measurement Uncertainties*” of the conducted emissions and radiated emissions measurements contained in Section 5 of this Test Report, and to provide a practical explanation of the meaning of these measurement uncertainties.

2. Statement of the Worst-Case Measurement Uncertainties for the Conducted and Radiated Emissions Measurements Contained in This Test Report

Table 1: Worst-Case Expanded Uncertainty "U" of Measurement for a k=2 Coverage Factor

Conducted Emissions Measurement Detection Systems	Applicable Frequency Range	"U" for a k=2 Coverage Factor
HP8568B Spectrum Analyzer with QPA and HP8447F Preamplifier	150 kHz - 30 MHz	+/- 3.0 dB
HP8566B Spectrum Analyzer with QPA and Preselector	9 kHz - 30 MHz	+/- 2.9 dB
Radiated Emissions Measurement Detection Systems	Applicable Frequency Range	"U" for a k=2 Coverage Factor
HP8568B Spectrum Analyzer with QPA & HP8447F Preamplifier	30 MHz - 200 MHz	+4.0 dB, -4.1 dB
HP8568B Spectrum Analyzer with QPA & HP8447F Preamplifier	200 MHz-1000 MHz	+/- 3.5 dB
HP8566B Spectrum Analyzer with QPA & Preselector	30 MHz - 200 MHz	+3.9 dB, -4.0 dB
HP8566B Spectrum Analyzer with QPA & Preselector	200 MHz-1000 MHz	+/- 3.4 dB
HP8566B Spectrum Analyzer with QPA & HP 8449A Preamplifier	1 GHz - 18 GHz	+2.5 dB, -2.6 dB
HP8566B Spectrum Analyzer with QPA & HP8449A Preamplifier	18 GHz - 40 GHz	+/- 3.4 dB

NOTES:

1. Applies to 3 and 10 meter measurement distances
2. Applies to all valid combinations of Transducers (i.e. LISNs, Line Voltage Probes, and Antennas, as appropriate)
3. Excludes the Repeatability of the EUT

Nemko USA, Inc.		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	30 of 36

3. Practical Explanation of the Meaning of the Conducted and Radiated Emissions Measurement Uncertainties

In general, a “Statement of Measurement Uncertainty” means that with a certain (specified) confidence level, the “true” value of a measurand will be between a (stated) upper bound and a (stated) lower bound.

In the specific case of EMC Measurements in this test report, the measurement uncertainties of the conducted emissions measurements and the radiated emissions measurements have been calculated in accordance with the method detailed in the following documents:

- o *ISO Guide to the Expression of Uncertainty in Measurement* (ISO, 1993)
- o NIS 81:1994, *The Treatment of Uncertainty in EMC Measurements* (NAMAS, 1994)
- o NIST Technical Note 1297(1994), *Guidelines for Evaluating and Expressing the Uncertainty of NIST Measurement Results* (NIST, 1994)

The calculation method used in these documents requires that the stated uncertainty of the measurements be expressed as an “expanded uncertainty”, U , with a $k=2$ coverage factor. The practical interpretation of this method of expressing measurement uncertainty is shown in the following example:

EXAMPLE: Assume that at 39.51 MHz, the (measured) radiated emissions level was equal to +26.5 dBuV/m, and that the +/- 2 standard deviations (i.e. 95% confidence level) measurement uncertainty was +/- 3.4 dB.

In the example above, the phrase “ $k = 2$ Coverage Factor” simply means that the measurement uncertainty is stated to cover +/-2 standard deviations (i.e. a 95% confidence interval) about the measurand. The measurand is the radiated emissions measurement of +26.5 dBuV/m at 39.51 MHz, and the 95% bounds for the uncertainty are -3.4 dB to + 3.4 dB. One can thus be 95% confident that the “true” value of the radiated emissions measurement is between +23.1 dBuV/m and +29.5 dBuV/m. *In effect, this means that in the above example there is only a 2.5% chance that the “true” radiated emissions value exceeds +29.5 dBuV/m.*

Nemko USA, Inc.		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	31 of 36

APPENDIX B

B. Nemko USA, Inc.'s Test Equipment & Facilities Calibration Program

Nemko USA, Inc. operates a comprehensive Periodic Calibration Program in order to ensure the validity of all test data. Nemko USA's Periodic Calibration Program is fully compliant to the requirements of NVLAP Policy Guide PG-1-1988, ANSI/NCSL Z540-1 (1994), ISO 10012-1 (1993-05-01), ISO Standard 17025, ISO-9000 and EN 45001. Nemko USA, Inc.'s calibrations program therefore meets or exceed the US national commercial and military requirements [N.B. ANSI/NCSL Z540-1 (1994) replaces MIL-STD-45662A].

Specifically, all of Nemko USA's *primary reference standard devices* (e.g. vector voltmeters, multimeters, attenuators and terminations, RF power meters and their detector heads, oscilloscope mainframes and plug-ins, spectrum analyzers, RF preselectors, quasi-peak adapters, interference analyzers, impulse generators, signal generators and pulse/function generators, field-strength meters and their detector heads, etc.) and certain *secondary standard devices* (e.g. RF Preamplifiers used in CISPR 11/22 and FCC Part 15/18 tests) are periodically recalibrated by:

- A Nemko USA-approved independent (third party) metrology laboratory that uses NIST-traceable standards and that is ISO Guide 25-accredited as a calibration laboratories by NIST; or,
- A Nemko USA-approved independent (third party) metrology laboratory that uses NIST-traceable standards and that is ISO Guide 25-accredited as a calibration laboratory by another accreditation body (such as A2LA) that is mutually recognized by NIST; or,
- A manufacturer of Measurement and Test Equipment (M&TE), if the manufacturer uses NIST-traceable standards and is ISO Guide 25-accredited as calibration laboratory either by NIST or by another accreditation body (such as A2LA) that is mutually recognized by NIST; or
- A manufacturer of M&TE (or by a Nemko USA-approved independent third party metrology laboratory) that is not ISO Guide 25-accredited. (In these cases, Nemko USA conducts an annual audit of the manufacturer or metrology laboratory for the purposes of proving traceability to NIST, ensuring that adequate and repeatable calibration procedures are being applied, and verifying conformity with the other requirements of ISO Guide 25).

<i>Nemko USA, Inc.</i>		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	32 of 36

In all cases, the entity performing the Calibration is required to furnish Nemko USA with a calibration test report and/or certificate of calibration, and a “calibration sticker” on each item of M&TE that is successfully calibrated.



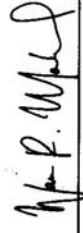
Calibration intervals are normally one year, except when the manufacture advises a shorter interval (e.g. the HP 8568B Spectrum Analyzer is recalibrated every six months) or if US Government directives or client requirements demand a shorter interval. Items of instrumentation/related equipment which fail during routine use, or which suffer visible mechanical damage (during use or while in transit), are sidelined pending repair and recalibration. (Repairs are carried out either in-house [if minor] or by a Nemko USA-approved independent [third party] metrology laboratory, or by the manufacturer of the item of M&TE).

Each antenna used for CISPR 11 and CISPR 22 and FCC Part 15 and Part 18 radiated emissions testing (and for testing to the equivalent European Norms) is calibrated annually by either a NIST (or A2LA) ISO Standard 17025-Accredited third-party Antenna Calibration Laboratory or by the antenna’s OEM if the OEM is NIST or A2LA ISO Standard 17025-accredited as an antenna calibration laboratory. The antenna calibrations are performed using the methods specified in Annex G.5 of CISPR 16-1(1993) or ANSI C63.5-1991, including the “Three-Antenna Method”. Certain other kinds of antennas (e.g. magnetic-shielded loop antennas) are calibrated annually by either a NIST (or A2LA) ISO Standard 17025-accredited third-party antenna calibration laboratory, or by the antenna’s OEM if the OEM is NIST or A2LA ISO Standard 17025-accredited as an antenna calibration laboratory using the procedures specified in the latest version of SAE ARP-958.


In accordance with FCC and other regulations, Nemko USA recalibrates its suite of antennas used for radiated emissions tests on an annual basis. These calibrations are performed as a precursor to the FCC-required annual revalidation of the Normalized Site Attenuation properties of Nemko USA’s Open Area Test Site. Nemko USA, Inc. uses the procedures given in both Subclause 16.6 and Annex G.2 of CISPR 16-1 (1993), and, ANSI C63.4-1992 when performing the normalized site attenuation measurements.

Nemko USA, Inc.		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	33 of 36

APPENDIX C
C. FCC and NVLAP Accreditation

<p align="center">United States Department of Commerce National Institute of Standards and Technology</p>	 <p align="center">NVLAP[®]</p> <p align="center">Certificate of Accreditation</p>	
<p>ISO/IEC 17025:1999 ISO 9002:1994</p>	<p align="center">NEMKO USA, INC. - SAN DIEGO EMC DIVISION SAN DIEGO, CA</p>	<p><i>is recognized by the National Voluntary Laboratory Accreditation Program for satisfactory compliance with criteria set forth in NIST Handbook 150:2001, all requirements of ISO/IEC 17025:1999, and relevant requirements of ISO 9002:1994. Accreditation is awarded for specific services, listed on the Scope of Accreditation, for:</i></p>
<p>December 31, 2004</p>		<p>For the National Institute of Standards and Technology NVLAP Lab Code: 200116-0</p>
<p align="center">ELECTROMAGNETIC COMPATIBILITY AND TELECOMMUNICATIONS</p>		
<p>Effective through</p>		
<p>NVLAP-01C (06-01)</p>		


Nemko USA, Inc.		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	34 of 36



National Institute of Standards and Technology National Voluntary Laboratory Accreditation Program

ISO/IEC 17025:1999
ISO 9002:1994

Scope of Accreditation



Page: 1 of 3

ELECTROMAGNETIC COMPATIBILITY AND TELECOMMUNICATIONS

NEMKO USA, INC. - SAN DIEGO EMC DIVISION
11696 Sorrento Valley Road, Suite F
San Diego, CA 92121
Mr. Ricky Hill
Phone: 858-755-5525 x207 Fax: 858-793-9914
E-Mail: rick.hill@nemko.com
URL: http://www.nemko.com

NVLAP LAB CODE 200116-0

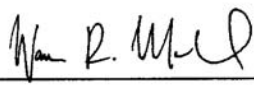
NVLAP Code Designation / Description

Emissions Test Methods:

12/CIS14	CISPR 14-1 (March 30, 2000): Limits and Methods of Measurement of Radio interference Characteristics of Household Electrical Appliances, Portable Tools and Similiar Electrical Apparatus - Part 1: Emissions
12/CIS14a	EN 55014-1 (1993) with Amendments A1 (1997) & A2 (1999)
12/CIS14b	AS/NZS 1044 (1995)
12/CIS14c	CNS 13783-1
12/CIS22	IEC/CISPR 22 (1997) and EN 55022 (1998): Limits and methods of measurement of radio disturbance characteristics of information technology equipment
12/CIS22a	IEC/CISPR 22 (1993): Limits and methods of measurement of radio disturbance characteristics of information technology equipment, Amendment 1 (1995) and Amendment 2 (1996)


December 31, 2004

Effective through



For the National Institute of Standards and Technology


Nemko USA, Inc.		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	35 of 36



National Institute of Standards and Technology National Voluntary Laboratory Accreditation Program

ISO/IEC 17025:1999
ISO 9002:1994

Scope of Accreditation



Page: 2 of 3

ELECTROMAGNETIC COMPATIBILITY AND TELECOMMUNICATIONS


NEMKO USA, INC. - SAN DIEGO EMC DIVISION

<i>NVLAP Code</i>	<i>Designation / Description</i>
12/CIS22b	CNS 13438 (1997): Limits and Methods of Measurement of Radio Interference Characteristics of Information Technology Equipment
12/EM02a	IEC 61000-3-2, Edition 2.1 (2001-10), EN 61000-3-2 (2000), and AS/NZS 2279.1 (2000): Electromagnetic compatibility (EMC) Part 3-2: Limits - Limits for harmonic current emissions (equipment input current <= 16 A)
12/EM03b	IEC 61000-3-3 (2002-03), edition 1.1: EMC - Part 3-3: Limits - Limitations of voltage changes, voltage fluctuations and flicker, in public low-voltage supply-systems, for equipment with rated current <=16 A per phase and not subject to conditional connections
12/F18	FCC OST/MP-5 (1986): FCC Methods of Measurement of Radio Noise Emissions for ISM Equipment (cited in FCC Method 47 CFR Part 18 - Industrial, Scientific, and Medical Equipment)
12/FCC15b	ANSI C63.4 (2001) with FCC Method - 47 CFR Part 15, Subpart B: Unintentional Radiators
12/T51	AS/NZS CISPR 22 (2002) and AS/NZS 3548 (1997): Electromagnetic Interference - Limits and Methods of Measurement of Information Technology Equipment

NVLAP LAB CODE 200116-0


December 31, 2004

Effective through



For the National Institute of Standards and Technology


Nemko USA, Inc.		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810	
DATE	DOCUMENT NAME	DOCUMENT #	PAGE
July, 26, 2004	Kyocera, Module 200 with new antenna	2004 024367 EMC	36 of 36



National Institute of Standards and Technology **NVLAP**® National Voluntary Laboratory Accreditation Program

ISO/IEC 17025:1999
ISO 9002:1994

Scope of Accreditation



DEPARTMENT OF COMMERCE
UNITED STATES OF AMERICA

ELECTROMAGNETIC COMPATIBILITY AND TELECOMMUNICATIONS

NEMKO USA, INC. - SAN DIEGO EMC DIVISION

NVLAP Code Designation / Description


Immunity Test Methods:

- 12/I01 IEC 61000-4-2, Edition 2.1 (2001) including Amds. 1 & 2 and EN 61000-4-2: Electrostatic Discharge Immunity Test
- 12/I02 IEC 61000-4-3 (2002) and EN 61000-4-3: Radiated Radio-Frequency Electromagnetic Field Immunity Test
- 12/I03 IEC 61000-4-4 (1995) + Amd. 1 (2000) & Amd. 2 (2001) and EN 61000-4-4: Electrical Fast Transient/Burst Immunity Test
- 12/I04 IEC 61000-4-5 (1995) + Amd. 1 (2000) and EN 61000-4-5: Surge Immunity Test
- 12/I05 IEC 61000-4-6, Edition 2.0 (2003) and EN 61000-4-6: Immunity to Conducted Disturbances, Induced by Radio-Frequency Fields
- 12/I06 IEC 61000-4-8, Edition 1.1 (2001) and EN 61000-4-8: Power Frequency Magnetic Field Immunity Test
- 12/I07 IEC 61000-4-11 (1994) + Amd. 1 (2000) and EN 61000-4-11: Voltage Dips, Short Interruptions and Voltage Variations Immunity Tests

NVLAP LAB CODE 200116-0

December 31, 2004

Effective through



For the National Institute of Standards and Technology